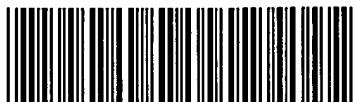


Search Notes

Application/Control No.

10/602,412

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

KNOWLES ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	242	6/22/2005	DB
	245		
	252		
	254		
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	259		
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

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